



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : 09/763,607  
Applicant : STÄHLER et al.  
Filed : May 11, 2001  
TC/A.U. : 1639  
Examiner : Ponnaluri, Padmashri  
  
Docket No. : 2923-436  
Customer No. : 06449  
Confirmation No. : 3440

INFORMATION DISCLOSURE STATEMENT

Director of the United States Patent  
and Trademark Office  
P.O. Box 1450  
Alexandria, Virginia 22313-1450

Dear Sir:

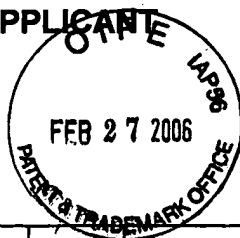
Under the provisions of 37 C.F.R. §§ 1.56, 1.97 and 1.98, Applicant submits herewith information that the Office may wish to consider in examination of the subject application. Applicants do not admit that the references submitted herein are prior art to the application. Materials submitted for consideration are listed on the attached Form PTO-1449. German language documents are cited because they were cited in related cases or similar cases having the same assignee in the United States or in Germany. English-language equivalents or abstracts also are submitted where available.

Applicants also would like to refer the examiner to commonly assigned co-pending application serial nos. 09/763,914; 10/129,130; 10/399,450; 10/727,566; and 10/895,981, which relate to similar subject matter.

Applicants believe that no fee is due in connection with the filing of this Statement. If, however, any fee is required, authorization is hereby given to charge the amount of such fee to Deposit Account No. 02-2135.

RESPECTFULLY SUBMITTED,					
NAME AND REG. NUMBER	Martha Cassidy Reg. No. 44,066 <i>BARBARA WEBB WALKER</i>				
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**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**



*Complete if Known*

Application Number	09/763,607
Filing Date	April 19, 2001
First Named Inventor	STÄHLER et al.
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Sheet

1

of

6

Attorney Docket Number 2923-436

**U.S. PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Number	Kind Code <sup>2</sup> (if known)		
		5,143,854		PIRRUNG et al.	09-01-1992
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		5,952,172		MEADE et al.	09-14-1999
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		Office <sup>3</sup> Code	Number <sup>4</sup>	Kind <sup>5</sup> (if known)			
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		Office <sup>3</sup> Code	Number <sup>4</sup>	Kind <sup>5</sup> (if known)			
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NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published	T <sup>2</sup>
		Bertsch et al., "Study of the Spatial Resolution of a New 3D Microfabrication Process: The Microstereophotolithography Using a Dynamic Mask-generator Technique," J. Photochemistry Photobiology A: Chemistry 107:275-281, 1997.	
		Hanley, et al. "Charge Transfer Device in Analytical Instrumentation," Anal. Chem. 68:A661-A667, 1996.	
		Hoheisel, "Oligomer-Chip Technology," Trends Biotechnol. 15(11):465-469, 1997.	
		Kirschner, et al., "Miniaturisierte NIR-Diodenarray-Spektrometer," GIT Labor-Fachzeitschrift (English Title Translation: Miniaturized NIR Diode Array Spectrometers), 402-404, 1998.	AB
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		Villemoes et al., "A Computerized Peptide Synthesizer with Feed back Control," Acta Chemica Scand. B 32:703-713, 1978.	
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